

**Search Notes**

Application/Control No.

10/713,036

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

HAGIWARA ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	281.1	8/24/5	ja
430	288.1	I	I

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR